

	Type	L #	Hits	Search Text	DBs	Time Stamp
1	BRS	L1	1519	(C-doped or carbon-doped or ((C or carbon) near5 dop\$4)) near10 (oxide or dioxide or SiO2 or SiO?sub\$2)	USPAT; US-PG PUB; EPO; JPO; DERW ENT; IBM_TD B	2002/12/23 10:53
2	BRS	L8	387	1 same (interlayer or ILD or intermetal or dielectric or insulat\$4)	USPAT; US-PG PUB; EPO; JPO; DERW ENT; IBM_TD B	2002/12/23 10:54

File 1:ERIC 1966-2002/ 1502
(c) format only 1502 The Dialog Corporation
File 2:INSPEC 1969-2002/Dec W3
(c) 2002 Institution of Electrical Engineers
File 3:INSPEC 1969-1982
(c) 1993 Institution of Electrical Engineers
File 4:INSPEC 1983-2002/Dec W3
(c) 2002 Institution of Electrical Engineers

Set Items Description
S1 42 (C-DOP? OR CARBON-DOP?) AND (OXIDE OR DIOXIDE OR SIO?)
S2 21 RD (unique items)
S3 13 S2 AND (LOW-K OR LOW)